

Data sheet acquired from Harris Semiconductor SCHS141H

March 1998 - Revised October 2003

CD54HC112, CD74HC112, CD54HCT112

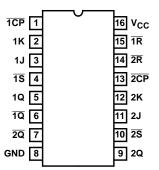
Dual J-K Flip-Flop with Set and Reset Negative-Edge Trigger

Features

- Hysteresis on Clock Inputs for Improved Noise Immunity and Increased Input Rise and Fall Times
- Asynchronous Set and Reset
- Complementary Outputs
- Buffered Inputs
- Typical $f_{MAX} = 60MHz$ at $V_{CC} = 5V$, $C_L = 15pF$, $T_{\Delta} = 25^{\circ}C$
- Fanout (Over Temperature Range)
- Bus Driver Outputs 15 LSTTL Loads
- Wide Operating Temperature Range . . . -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5V
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility,
 V_{IL}= 0.8V (Max), V_{IH} = 2V (Min)
 - CMOS Input Compatibility, $I_I \le 1\mu A$ at V_{OL} , V_{OH}

Pinout

CD54HC112, CD54HCT112 (CERDIP) CD74HC112 (PDIP, SOIC, SOP, TSSOP) CD74HCT112 (PDIP) TOP VIEW



Description

The 'HC112 and 'HCT112 utilize silicon-gate CMOS technology to achieve operating speeds equivalent to LSTTL parts. They exhibit the low power consumption of standard CMOS integrated circuits, together with the ability to drive 10 LSTTL loads.

These flip-flops have independent J, K, Set, Reset, and Clock inputs and Q and \overline{Q} outputs. They change state on the negative-going transition of the clock pulse. Set and Reset are accomplished asynchronously by low-level inputs.

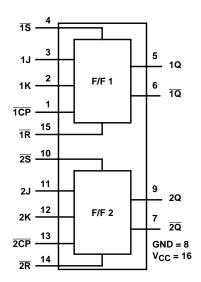
The HCT logic family is functionally as well as pincompatible with the standard LS logic family.

Ordering Information

| PART NUMBER | TEMP. RANGE (°C) | PACKAGE |
|---------------|---------------------|--------------|
| CD54HC112F3A | -55 to 125 | 16 Ld CERDIP |
| CD54HCT112F3A | -55 to 125 | 16 Ld CERDIP |
| CD74HC112E | -55 to 125 | 16 Ld PDIP |
| CD74HC112MT | -55 to 125 | 16 Ld SOIC |
| CD74HC112M96 | -55 to 125 | 16 Ld SOIC |
| CD74HC112NSR | -55 to 125 | 16 Ld SOP |
| CD74HC112PW | -55 to 125 | 16 Ld TSSOP |
| CD74HC112PWR | -55 to 125 | 16 Ld TSSOP |
| CD74HC112PWT | -55 to 125 | 16 Ld TSSOP |
| CD74HCT112E | -55 to 125 | 16 Ld PDIP |

NOTE: When ordering, use the entire part number. The suffixes 96 and R denote tape and reel. The suffix T denotes a small-quantity reel of 250.

Functional Diagram



TRUTH TABLE

| | | OUT | PUTS | | | |
|---|---|----------|------|---|------------|------------|
| S | R | CP | J | К | Q | Q |
| L | Н | Х | X | Х | Н | L |
| Н | L | Х | Х | Х | L | Н |
| L | L | Х | Х | Х | H (Note 1) | H (Note 1) |
| Н | Н | \ | L | L | No C | hange |
| Н | Н | \ | Н | L | Н | L |
| Н | Н | \ | L | Н | L | Н |
| Н | Н | \ | Н | Н | Tog | ggle |
| Н | Н | Н | Х | Х | No C | hange |

H= High Level (Steady State)

L= Low Level (Steady State)

X= Don't Care ↓= High-to-Low Transition

NOTE:

1. Output states unpredictable if both \overline{S} and \overline{R} go High simultaneously after both being low at the same time.

Absolute Maximum Ratings

Thermal Information

| Package Thermal Impedance, θ_{JA} (see Note 2): |
|----------------------------------------------------------------|
| E (PDIP) Package |
| NS (SOP) Package64°C/W |
| D (SOIC) Package |
| PW (TSSOP) Package 108°C/W |
| Maximum Junction Temperature (Hermetic Package or Die) . 175°C |
| Maximum Junction Temperature (Plastic Package) 150°C |
| Maximum Storage Temperature Range65°C to 150°C |
| Maximum Lead Temperature (Soldering 10s)300°C |

Operating Conditions

| Temperature Range, T _A |
|-------------------------------------------------------------|
| Supply Voltage Range, V _{CC} |
| HC Types2V to 6V |
| HCT Types |
| DC Input or Output Voltage, V _I , V _O |
| Input Rise and Fall Time, t _r , t _f |
| 2V |
| 4.5V |
| 6V |

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

2. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

| | TEST | | | | 25°C | | -40°C T | O 85°C | -55°C T | O 125 ⁰ C | | |
|--------------------------|-----------------|---------------------------|---------------------|---------------------|------|-----|---------|--------|---------|----------------------|------|-------|
| PARAMETER | SYMBOL | V _I (V) | I _O (mA) | v _{cc} (v) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| HC TYPES | | | | | | | | | | | | |
| High Level Input | V _{IH} | - | - | 2 | 1.5 | - | - | 1.5 | - | 1.5 | - | V |
| Voltage | | | | 4.5 | 3.15 | - | - | 3.15 | - | 3.15 | - | V |
| | | | | 6 | 4.2 | - | - | 4.2 | - | 4.2 | - | V |
| Low Level Input | V _{IL} | - | - | 2 | - | - | 0.5 | - | 0.5 | - | 0.5 | V |
| Voltage | | | | 4.5 | - | - | 1.35 | - | 1.35 | - | 1.35 | V |
| | | | | 6 | - | - | 1.8 | - | 1.8 | - | 1.8 | V |
| High Level Output | V _{OH} | V _{IH} or | -0.02 | 2 | 1.9 | - | - | 1.9 | - | 1.9 | - | V |
| Voltage CMOS Loads | | V_{IL} | | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | ٧ |
| | | | | 6 | 5.9 | - | - | 5.9 | - | 5.9 | - | V |
| High Level Output | | | - | - | - | - | - | - | - | - | - | ٧ |
| Voltage TTL Loads | | | -4 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V |
| | | | -5.2 | 6 | 5.48 | - | - | 5.34 | - | 5.2 | - | ٧ |
| Low Level Output | V _{OL} | V _{IH} or | 0.02 | 2 | - | - | 0.1 | - | 0.1 | - | 0.1 | ٧ |
| Voltage CMOS Loads | | V_{IL} | | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
| | | | | 6 | - | - | 0.1 | - | 0.1 | - | 0.1 | ٧ |
| Low Level Output | | | - | - | - | - | - | - | - | - | - | V |
| Voltage TTL Loads | | | 4 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| | | | 5.2 | 6 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| Input Leakage Current | II | V _{CC} or GND | - | 6 | - | - | ±0.1 | - | ±1 | - | ±1 | μА |

DC Electrical Specifications (Continued)

| | | | ST ITIONS | | | 25°C -40°C TO 85°C | | -55°C T | O 125°C | | | |
|----------------------------------------------------------------------|------------------------------|---------------------------------------|---------------------|---------------------|------|--------------------|------|---------|---------|-----|-----|-------|
| PARAMETER | SYMBOL | V _I (V) | I _O (mA) | V _{CC} (V) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| Quiescent Device Current | Icc | V _{CC} or GND | 0 | 6 | - | - | 4 | - | 40 | - | 80 | μА |
| HCT TYPES | | | | | | | | | | | | |
| High Level Input Voltage | V _{IH} | - | - | 4.5 to 5.5 | 2 | - | - | 2 | - | 2 | - | V |
| Low Level Input Voltage | V _{IL} | - | - | 4.5 to 5.5 | - | - | 0.8 | - | 0.8 | - | 0.8 | V |
| High Level Output Voltage CMOS Loads | V _{OH} | V _{IH} or V _{IL} | -0.02 | 4.5 | 4.4 | - | - | 4.4 | - | 4.4 | - | V |
| High Level Output Voltage TTL Loads | | | -4 | 4.5 | 3.98 | - | - | 3.84 | - | 3.7 | - | V |
| Low Level Output Voltage CMOS Loads | V _{OL} | V _{IH} or V _{IL} | 0.02 | 4.5 | - | - | 0.1 | - | 0.1 | - | 0.1 | V |
| Low Level Output Voltage TTL Loads | | | 4 | 4.5 | - | - | 0.26 | - | 0.33 | - | 0.4 | V |
| Input Leakage Current | II | V _{CC} and GND | - | 5.5 | - | | ±0.1 | - | ±1 | - | ±1 | μА |
| Quiescent Device Current | Icc | V _{CC} or GND | 0 | 5.5 | - | - | 4 | - | 40 | - | 80 | μА |
| Additional Quiescent Device Current Per Input Pin: 1 Unit Load | ΔI _{CC} (Note 3) | V _{CC} - 2.1 | - | 4.5 to 5.5 | - | 100 | 360 | - | 450 | - | 490 | μА |

NOTE:

HCT Input Loading Table

| INPUT | UNIT LOADS |
|-----------------------------------------|------------|
| <u>1S</u> , <u>2S</u> | 0.5 |
| 1K, 2K | 0.6 |
| 1R, 2R | 0.65 |
| 1J, 2J, 1CP , 2CP | 1 |

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Specifications table, e.g., $360\mu A$ max at $25^{\circ}C$.

Prerequisite For Switching Specifications

| | TEST | | v _{cc} | | 25°C | | -40°C TO 85°C | | -55°C TO 125°C | | |
|----------------|----------------|------------|-----------------|-----|------|-----|---------------|-----|----------------|-----|-------|
| PARAMETER | SYMBOL | CONDITIONS | (V) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| HC TYPES | | | | | | | | | | | |
| Pulse Width CP | t _W | - | 2 | 80 | - | - | 100 | - | 120 | - | ns |
| | | | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| | | | 6 | 14 | - | - | 17 | - | 20 | - | ns |

^{3.} For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

Prerequisite For Switching Specifications (Continued)

| | | TEST | v _{cc} | | 25°C | | -40°C T | O 85°C | -55°C T | O 125°C | |
|------------------------------------------------------------------------------------|------------------|------------|-----------------|-----|------|-----|---------|--------|---------|---------|-------|
| PARAMETER | SYMBOL | CONDITIONS | (V) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| Pulse Width R, S | t _W | - | 2 | 80 | - | - | 100 | - | 120 | - | ns |
| | | | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| | | | 6 | 14 | - | - | 17 | - | 20 | - | ns |
| Setup Time J, K, to CP | t _{SU} | - | 2 | 80 | - | - | 100 | - | 120 | - | ns |
| | | | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| | | | 6 | 14 | - | - | 17 | - | 20 | - | ns |
| Hold Time J, K, to \overline{CP} | t _H | - | 2 | 0 | - | - | 0 | - | 0 | - | ns |
| | | | 4.5 | 0 | - | - | 0 | - | 0 | - | ns |
| | | | 6 | 0 | - | - | 0 | - | 0 | - | ns |
| Removal Time \overline{R} to \overline{CP} , \overline{S} to \overline{CP} | t _{REM} | - | 2 | 80 | - | - | 100 | - | 120 | - | ns |
| | | | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| | | | 6 | 14 | - | - | 17 | - | 20 | - | ns |
| CP Frequency | f _{MAX} | - | 2 | 6 | - | - | 5 | - | 4 | - | MHz |
| | | | 4.5 | 30 | - | - | 25 | - | 20 | - | MHz |
| | | | 6 | 35 | - | - | 29 | - | 23 | - | MHz |
| HCT TYPES | | | | | | | | | | | |
| Pulse Width CP | tsu | - | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| Pulse Width R, S | t _W | - | 4.5 | 18 | - | - | 23 | - | 27 | - | ns |
| Setup Time J, K, to CP | t _H | - | 4.5 | 16 | - | - | 20 | - | 24 | - | ns |
| Hold Time J, K, to CP | t _{REM} | - | 4.5 | 3 | - | - | 3 | - | 3 | - | ns |
| Removal Time \overline{R} to \overline{CP} , \overline{S} to \overline{CP} | t _W | - | 4.5 | 20 | - | - | 25 | - | 30 | - | ns |
| CP Frequency | f _{MAX} | - | 4.5 | 30 | - | - | 25 | - | 20 | - | MHz |

Switching Specifications Input $t_{\text{f}},\,t_{\text{f}}=6\text{ns}$

| | | TEST | v _{cc} | | 25°C | | -40°C T | O 85°C | -55°C T | O 125°C | |
|----------------------------------------|-------------------------------------|-----------------------|-----------------|-----|------|-----|---------|--------|---------|---------|-------|
| PARAMETER | SYMBOL | CONDITIONS | (V) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| HC TYPES | | | | | | | | | | | |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 2 | - | - | 175 | - | 220 | - | 265 | ns |
| CP to Q, Q | | C _L = 50pF | 4.5 | - | - | 35 | - | 44 | - | 53 | ns |
| | | C _L = 15pF | 5 | - | 14 | - | - | - | - | - | ns |
| | | C _L = 50pF | 6 | - | - | 30 | - | 37 | - | 45 | ns |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 2 | - | - | 155 | - | 195 | - | 235 | ns |
| \overline{S} to Q , \overline{Q} | | C _L = 50pF | 4.5 | - | - | 31 | - | 39 | - | 47 | ns |
| | | C _L = 15pF | 5 | - | 13 | - | - | - | - | - | ns |
| | | C _L = 50pF | 6 | - | - | 26 | - | 33 | - | 40 | ns |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 2 | - | - | 180 | - | 225 | - | 270 | ns |
| \overline{R} to Q, \overline{Q} | | C _L = 50pF | 4.5 | - | - | 36 | - | 45 | - | 54 | ns |
| | | C _L = 15pF | 5 | - | 15 | - | - | - | - | - | ns |
| | | C _L = 50pF | 6 | - | - | 31 | - | 38 | - | 46 | ns |

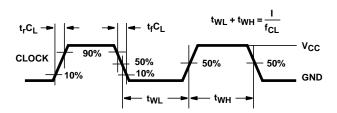
Switching Specifications Input t_r , $t_f = 6ns$ (Continued)

| | | TEST | v _{cc} | | 25°C | | -40°C T | O 85°C | -55°C T | O 125 ⁰ C | |
|-------------------------------------------------------------------|-------------------------------------|-----------------------|-----------------|-----|------|-----|---------|--------|---------|----------------------|-------|
| PARAMETER | SYMBOL | CONDITIONS | (V) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNITS |
| Output Transition Time | t _{TLH} , t _{THL} | C _L = 50pF | 2 | - | - | 75 | - | 95 | - | 110 | ns |
| | | C _L = 50pF | 4.5 | - | - | 15 | - | 19 | - | 22 | ns |
| | | C _L = 50pF | 6 | - | - | 13 | - | 16 | - | 19 | ns |
| Input Capacitance | CI | - | - | - | - | 10 | - | 10 | - | 10 | pF |
| CP Frequency | f _{MAX} | C _L = 15pF | 5 | - | 60 | - | - | - | - | - | MHz |
| Power Dissipation Capacitance (Notes 4, 5) | C _{PD} | - | 5 | - | 12 | - | - | - | - | - | pF |
| HCT TYPES | | | | | | | | | • | • | |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 4.5 | - | - | 35 | - | 44 | - | 53 | ns |
| \overline{CP} to Q, \overline{Q} | | C _L = 15pF | 5 | - | 14 | - | - | - | - | - | ns |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 4.5 | - | - | 32 | - | 40 | - | 48 | ns |
| S to Q, Q | | C _L = 15pF | 5 | - | 13 | - | - | - | - | - | ns |
| Propagation Delay, | t _{PLH} , t _{PHL} | C _L = 50pF | 4.5 | - | - | 37 | - | 46 | - | 56 | ns |
| $\overline{\mathbb{R}}$ to \mathbb{Q} , $\overline{\mathbb{Q}}$ | | C _L = 15pF | 5 | - | 14 | - | - | - | - | - | ns |
| Output Transition Time | t _{TLH} , t _{THL} | C _L = 50pF | 4.5 | - | - | 15 | - | 19 | - | 22 | ns |
| Input Capacitance | Cl | - | - | - | - | 10 | - | 10 | - | 10 | pF |
| CP Frequency | f _{MAX} | CL = 15pF | 5 | - | 60 | - | - | - | - | - | MHz |
| Power Dissipation Capacitance (Notes 4, 5) | C _{PD} | - | 5 | - | 20 | - | - | - | - | | pF |

NOTES:

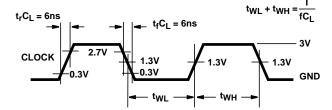
- 4. CPD is used to determine the dynamic power consumption, per flip-flop.
- 5. $P_D = C_{PD} V_{CC}^2 f_i + \Sigma C_L f_o$ where f_i = input frequency, f_o = output frequency, C_L = output load capacitance, V_{CC} = supply voltage.

Test Circuits and Waveforms



NOTE: Outputs should be switching from 10% V $_{CC}$ to 90% V $_{CC}$ in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 1. HC CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH



NOTE: Outputs should be switching from 10% V $_{CC}$ to 90% V $_{CC}$ in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 2. HCT CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH

Test Circuits and Waveforms (Continued)

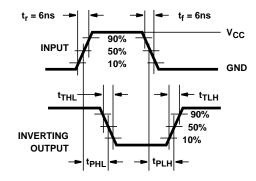


FIGURE 3. HC AND HCU TRANSITION TIMES AND PROPAGA-TION DELAY TIMES, COMBINATION LOGIC

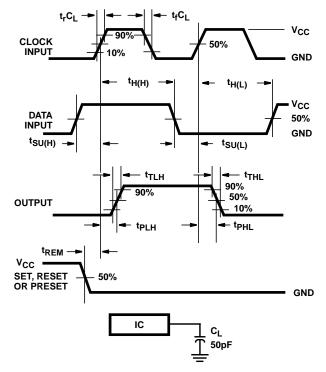


FIGURE 5. HC SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

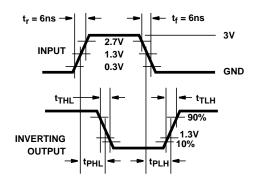


FIGURE 4. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

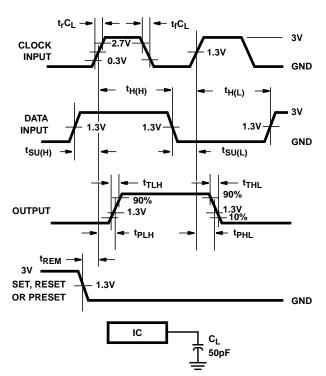


FIGURE 6. HCT SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS





25-Sep-2013

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package Drawing | Pins | Package Qty | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|--------|--------------|--------------------|------|----------------|----------------------------|------------------|--------------------|--------------|---------------------------------|---------|
| 5962-8970201EA | ACTIVE | CDIP | J | 16 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | 5962-8970201EA CD54HCT112F3A | Samples |
| CD54HC112F3A | ACTIVE | CDIP | J | 16 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | 8408801EA CD54HC112F3A | Samples |
| CD54HCT112F3A | ACTIVE | CDIP | J | 16 | 1 | TBD | A42 | N / A for Pkg Type | -55 to 125 | 5962-8970201EA CD54HCT112F3A | Samples |
| CD74HC112E | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD74HC112E | Samples |
| CD74HC112EE4 | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD74HC112E | Samples |
| CD74HC112M96 | ACTIVE | SOIC | D | 16 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112M96E4 | ACTIVE | SOIC | D | 16 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112M96G4 | ACTIVE | SOIC | D | 16 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112MT | ACTIVE | SOIC | D | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112MTE4 | ACTIVE | SOIC | D | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112MTG4 | ACTIVE | SOIC | D | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112NSR | ACTIVE | so | NS | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112NSRE4 | ACTIVE | SO | NS | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112NSRG4 | ACTIVE | so | NS | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HC112M | Samples |
| CD74HC112PW | ACTIVE | TSSOP | PW | 16 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWE4 | ACTIVE | TSSOP | PW | 16 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWG4 | ACTIVE | TSSOP | PW | 16 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |





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| Orderable Device | Status | Package Type | Package | Pins | Package | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|------------------|--------|--------------|---------|------|---------|----------------------------|------------------|--------------------|--------------|----------------|---------|
| | (1) | | Drawing | | Qty | (2) | | (3) | | (4/5) | |
| CD74HC112PWR | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWRE4 | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWRG4 | ACTIVE | TSSOP | PW | 16 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWT | ACTIVE | TSSOP | PW | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWTE4 | ACTIVE | TSSOP | PW | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HC112PWTG4 | ACTIVE | TSSOP | PW | 16 | 250 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM | -55 to 125 | HJ112 | Samples |
| CD74HCT112E | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD74HCT112E | Samples |
| CD74HCT112EE4 | ACTIVE | PDIP | N | 16 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type | -55 to 125 | CD74HCT112E | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



PACKAGE OPTION ADDENDUM

25-Sep-2013

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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OTHER QUALIFIED VERSIONS OF CD54HC112, CD54HC112, CD74HC112, CD74HC1112:

Catalog: CD74HC112, CD74HCT112

Military: CD54HC112, CD54HCT112

NOTE: Qualified Version Definitions:

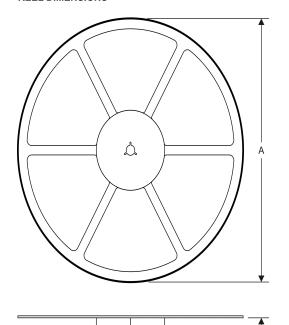
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

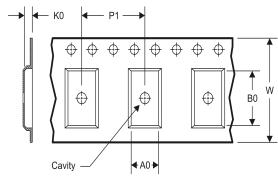
www.ti.com 14-Jul-2012

TAPE AND REEL INFORMATION

REEL DIMENSIONS







| A0 | Dimension designed to accommodate the component width |
|----|-----------------------------------------------------------|
| В0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

TAPE AND REEL INFORMATION

*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| CD74HC112M96 | SOIC | D | 16 | 2500 | 330.0 | 16.4 | 6.5 | 10.3 | 2.1 | 8.0 | 16.0 | Q1 |
| CD74HC112NSR | SO | NS | 16 | 2000 | 330.0 | 16.4 | 8.2 | 10.5 | 2.5 | 12.0 | 16.0 | Q1 |
| CD74HC112PWR | TSSOP | PW | 16 | 2000 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| CD74HC112PWT | TSSOP | PW | 16 | 250 | 330.0 | 12.4 | 6.9 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |

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*All dimensions are nominal

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|-----------------------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| CD74HC112M96 | SOIC | D | 16 | 2500 | 333.2 | 345.9 | 28.6 |
| CD74HC112NSR | SO | NS | 16 | 2000 | 367.0 | 367.0 | 38.0 |
| CD74HC112PWR | TSSOP | PW | 16 | 2000 | 367.0 | 367.0 | 35.0 |
| CD74HC112PWT | TSSOP | PW | 16 | 250 | 367.0 | 367.0 | 35.0 |

14 LEADS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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